jc882 U.S. PTO
10/06/00

Case No. DR-224 **(50564)**

10-10-00

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For: **SYSTEM AND METHOD FOR BROADBAND ANALYSIS OF TELEPHONE LOCAL LOOP**

Enclosed are:

[X] Patent Application: 35 pages, 43 claims.

[X] 3 sheets of drawings.

[X] Citation Under 37 CFR 1.97 and PTO-1449.

Declaration and Filing Fee **NOT ENCLOSED.**

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SYSTEM AND METHOD FOR BROADBAND ANALYSIS OF TELEPHONE LOCAL LOOP

Field of the Invention

The present invention is related to communication systems and methods for analyzing same, and more particularly, this invention relates to qualifying and quantifying a telephone local loop for wideband services and recommending the best technology in wideband services for the local loop under test.

Background of the Invention

Broadband services supplied to a customer over the copper local loop are becoming increasingly more popular with the rise of the Internet and other technologies requiring wideband local loop applications. It is well known that Digital Subscriber Line (DSL) technology improves the bandwidth of existing analog phone systems. Data throughput of up to 52 Mbits/sec can be provided over small distances, which increase as the data rate is lowered.

The customer local loop refers to the existing twisted-pair wire that extends between a local telephone company switching office and most homes and offices. As is well known, the bandwidth was typically limited to 3,000 Hz, because of the relegation of the local twisted-pair wire to the voice telephone system and its audio frequencies. In the past, most telephone switching equipment was designed to cut off signals

from about 4,000 Hz and filter noise off the voice line.

More phone companies are upgrading their switching equipment to obtain a greater bandwidth since the advent of the Internet. The different technologies of DSL, also referred to as xDSL, range in speed from 16K bits/sec to 52 Mbits/sec, and can be either symmetrical, where traffic flows at the same speed in both directions or asymmetrical, where the downstream capacity is higher than the upstream capacity. Asymmetrical DSL services can typically be used by Internet users at home, for example, allowing a user to download more graphic files and upload only commands.

As the data rate increases, the carrying distance for xDSL service decreases. Also, xDSL connections are point-to-point and are always connected with no dial up, and no switching. There is always a direct connection into a carrier's frame relay, ATM (Asynchronous Transfer Mode), or an Internet-connect system.

The different types of xDSL service include High-bit-rate Digital Subscriber Line (HDSL), which provides T1 data rates of 1.544 Mbits/sec over about 12,000 feet of line length. Two lines are used and voice services are not operable. It is usually provided for feeder lines, interexchange connections, Internet servers, and private data networks.

Symmetrical Digital Subscriber Line (SDSL) is a symmetrical, bidirectional DSL service using one twisted-pair wire and operates above the voice frequency. This allows voice and data to be carried on the same wire.

Asymmetrical Digital Subscriber Line (ADSL) allows a much greater downstream data rate. It is operable best for Internet services and the rate varies, depending on the downstream rate and downstream

distance. For example, when using a downstream rate of 1.544 Mbits/sec, the downstream maximum line distance is about 18,000 feet. If the downstream rate is increased to 8.448 Mbits/sec, the downstream maximum line distance is only about 9,000 feet.

Very high-bit-rate Digital Subscriber Line (VDSL) is a very high asymmetrical data rate. It allows an upstream rate of about 12.96 Mbits/sec with a maximum line distance of about 4,500 feet, and an upstream rate of about 51.84 Mbits/sec, with an upstream maximum line distance of about 1,000 feet.

Rate-Adaptive Digital Subscriber Line (RADSL) is similar to ADSL, but includes a rate-adapted feature to adjust transmission speed to match the quality of the line and length of the line. It is possible to use a line-pulling technique to establish a connection speed when the line is first established.

ISDN DSL (IDSL) operates at about 128 Kbps, which is less than most other DSL technologies. It is a dedicated service as compared to standard ISDN services. IDSL is data-only and lacks any analog voice line.

Although xDSL technologies are becoming increasingly important, there is still an inability to adequately prequalify the local copper loops accurately. This has been a significant obstacle for the Local Exchange Carriers (LECS). Prequalification has now become critical because the different xDSL technology services is dependent on the design and quality of the outside plant (OSP) and the presence of load coils, which block DSL transmission. Prequalification also determines if the local loop is capable of supporting DSL transmission prior to any attempt to provide service. There will be significant cost savings for the LEC if the loop could be qualified

without having to dispatch technicians to either a central office (CO) or to the customer premises. As noted above, there are a number of DSL services and even more are projected by the industry. Thus, there is a strong need for an even more improved automated testing capability to handle the growing line volume of xDSL technologies. It is necessary, then, to predict a local loop's capability to support xDSL services across an entire range of frequencies over which this technology can operate.

There are some systems for estimating the ability of a subscriber loop to support broadband services, such as disclosed in U.S. Patent No. 6,091,713 to Lechleter et al. Also, there are various Wideband Test Packs (WTP) and Remote Test Units (RTU), such as manufactured by Harris Corporation of Melbourne, Florida, that are used for diagnosing service-affecting problems for all xDSL and ISDN services. These units can act as an intelligent test head, as known to those skilled in the art. Greater efficiency in testing, qualifying, and quantifying the local loop is desired, however.

Summary of the Invention

It is therefore an object of the present invention to provide an improved method and system of analyzing a telephone local loop for broadband services.

In accordance with the present invention, the method and system analyzes a telephone local loop by first determining the physical loop faults within the local loop. The local loop is qualified for a particular Digital Subscriber Line (DSL) technology. The local loop is then quantified by calculating the signal-to-noise ratio and calculating the data rates of

the local loop for a particular DSL technology. In one aspect of the present invention, the DSL technology comprises symmetric DSL technology, and in another aspect of the present invention, it comprises asymmetric DSL technology.

In yet another aspect of the present invention, the local loop is quantified by modeling the local loop, including the resistance, inductance, capacitance and conductance (RLCG) primary constants and the line parameters for various segments of the local loop. The line parameters can be modeled based on the frequency and RLCG primary constants.

Physical loop faults can be determined by obtaining plant data and test results from a test head within a communications network containing the local loop. The local loop can be qualified by testing for the presence or absence of load coils, impulse noise counts and ringer counts, and then comparing the counts with thresholds specified by given DSL technologies. The local loop can be quantified by calculating downstream and upstream data rates based on the downstream and upstream transmit signal power spectral densities, insertion loss, and noise versus frequency measurements. The insertion loss of the local loop can be calculated with or without bridge tabs based on the cable type, wire gauge, loop length and its topology. The local loop can also be quantified by selecting a particular DSL technology from a configurable list of DSL technologies and analyzing each technology within the list until the local loop qualifies.

Brief Description of the Drawings

Other objects, features and advantages of the present invention will become apparent from the detailed description of the invention which follows,

when considered in light of the accompanying drawings in which:

FIG. 1 is a block diagram of a network element interconnection that uses a Remote Testing Unit and Wideband Test Pack for testing the local loop, in accordance with one aspect of the present invention.

FIG. 2 is a high level flow chart illustrating one basic method used in the present invention for analyzing the local loop for wideband services.

FIG. 3 is a more detailed flow chart of an example of the algorithm used for testing the local loop, in accordance with the present invention.

Detailed Description of the Preferred Embodiments

The present invention will now be described more fully hereinafter with reference to the accompanying drawings, in which preferred embodiments of the invention are shown. This invention may, however, be embodied in many different forms and should not be construed as limited to the embodiments set forth herein. Rather, these embodiments are provided so that this disclosure will be thorough and complete, and will fully convey the scope of the invention to those skilled in the art. Like numbers refer to like elements throughout.

The present invention is advantageous and provides a system and method for analyzing the customer local copper loop using a software module, also called the Bandwidth Analysis Tool (BAT) throughout this description. This software module analyzes the raw data results from a Wideband Test Pack (WTP), such as manufactured by Harris Corporation of Melbourne, Florida, and also the plant record data, to qualify and quantify the local copper loop under test for a

particular xDSL technology. Alternatively, the Bandwidth Analysis Tool can also analyze the WTP data and plant record data to recommend the best technology for a given application.

This analysis uses loop qualification and quantification based on WTP raw data results, plant record data, loop topology and the loop insertion loss. The loop is modeled to calculate the insertion loss, with or without bridged taps, taking into account the cable type, the wire gauge, loop length, and its topology. A signal-to-noise ratio of the receive signal is calculated using the specific technology, as dependent on the transmit signal power spectral density templates and noise versus frequency data results from the Wideband Test Pack. The downstream and upstream data rates are calculated for the local loop under test.

The algorithm for loop qualification and quantification can have two principle functions: (1) determining physical loop faults; and (2) analyzing for xDSL technology.

The determination of physical loops is performed by testing for shorts, opens, load coils, and similar factors. The xDSL technology testing analyzes for symmetric DSL or asymmetric DSL, as appropriate. Loop qualification is accomplished by testing for the presence or absence of load coils, impulse noise counts, ringer counts, and then comparing the counts with the thresholds specified by the given technologies. Loop quantification is accomplished for xDSL technologies by modeling the local loop under test, calculating the signal-to-noise ratio, and calculating the data rates. In the case of symmetric DSL technologies, downstream and upstream data rates are equal, as known to those skilled in the art. In

the case of asymmetric DSL technologies, downstream and upstream data rates are calculated based on downstream and upstream transmit signal power spectral densities (PSD), insertion loss, and noise versus frequency measurements.

Loop quantification for VDSL is performed as a special case because of the restrictions of the bandwidth of the Wideband Test Pack. In the case of VDSL, loop quantification is accomplished based on loop topology, rather than using signal-to-noise ratios. In a "recommend best technology" mode of the system, the technology is set to a DSL technology from a configurable list of technologies, and the analysis is performed for each technology in the list until the loop qualifies. Otherwise, the system continues analysis of the loop for the next technology on the list. If the list is exhausted, the program returns a "failed" status. If the loop qualifies for a DSL technology, the status is set to a "pass", and the recommended technology is set to the current technology for which the loop has been analyzed, and any calculated data rates are returned.

Referring now to FIG. 1, there is illustrated a typical Remote Test Unit to network element interconnection that uses a Wideband Test Pack and Bandwidth Analysis Tool software module of the present invention. Naturally, the Bandwidth Analysis Tool used as a software module can be adapted for use with different network elements and components, as suggested by those skilled in the art. The example as illustrated shows only one out of many different configurations.

The block diagram of FIG. 1 illustrates two home premises **10,12** having telephones and computers at the customer premise. These are connected to a remote

Incumbent Local Exchange Carrier (ILEC) **14** having a Digital Loop Carrier **16** and a Remote Test Unit **18,** such as a model 107A/F Remote Test Unit as manufactured by Harris Corporation of Melbourne, Florida, and a Wideband Test Pack, such as are manufactured by Harris Corporation. A Central Office switch **20** as part of the Central office (CO) **20a** is connected to the Digital Loop Carrier **16** and to the other customer premises **12** via a Main Distribution Frame (MDF) **22.** An Intermediate Distribution Frame **24** connects to the MDF **22.** A DSL Access Multiplexer (DSLAM) **30** is connected to the Intermediate Distribution Frame **24,** with operative connection to a Remote Test Unit **32,** such as a Harris model 105A, a Carrier Test Access Switch (CTAS) **34,** such as manufactured by Harris Corporation, a Remote Test Unit **36,** such as a Harris model 107A/F, and a Wideband Test Pack **38,** located in a Colocation Cage **40.** The Remote Test Unit is connected to a stand alone PC **42** that could include a Test Access Express circuit **42a,** similar in function to a Test Access Controller as manufactured by Harris Corporation. A Call Center **50** includes, as is normal in this example, an operator **52,** the Bandwidth Analysis Tool **54** of the present invention shown in block diagram and representing a software module, and an Interactive Voice Access Server **56.**

A central component of the system is a Test Access Controller (TAC) **60,** which is a sophisticated software-based element of a test operational support system. It provides communication and a control interface with remote test heads and interfaces with legacy systems and databases. It can be accessed through a graphical user interface **61** that is

windows-based to facilitate communications with call center personnel and other test operators.

As noted before, the test heads can include the Remote Test Unit, such as the model 105A, designed for use in the Central Office, and the model 107A/F, such as for a DLC environment and CLEC Colocation Cages. These Remote Test Units access lines by various ways, including a Carrier Test Access Switch to provide capacity of 128 lines, or a daisy-chaining circuit with up to seven other carrier test access switches to provide test access to over 1,000 lines. The Remote Test Unit can have direct access through the DSLAM or DLC, if there is metallic test access capability.

The Wideband Test Pack performs high frequency testing via the Remote Test Units, measuring high-frequency loss, noise margin, bridged tabs, impulse noise and longitudinal balance. The Wideband Test Packet can provide data used by the Bandwidth Analysis Tool to determine what xDSL services a provider can offer a customer, in accordance with the present invention. The Wideband Test Pack can also generate tones for noise analysis. The Interactive Voice Access (IVA) technology shown at the Call Center can allow field technicians at either an ILEC or CLEC to gain access to testing functions and database records.

A Wideband Test Pack, such as manufactured by Harris Corporation, allows accurate, single-ended testing. The Wideband Test Pack can detect bridge taps, measure wideband circuit balance, measure high-frequency background noise ,and provide a frequency spectrum line profile for identifying noise impairment. Also, double-ended tests can be performed to isolate problems.

Some of the operating ranges of a Wideband Test Pack that could be used in the present invention are listed below. Although these are only examples, these figures give a general idea of the type of specifications that a Wideband Test Pack or other device could have to obtain the raw data used by the Bandwidth Analysis Tool of the present invention.

Wideband Noise - Measures the total Gaussian noise up to 1500 KHz:

Frequency Range	4 KHz to 1500 KHz
Noise Level Range	0 dBrN to +120 dBrN
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

Power Spectral Density/Noise Margin - Provides detailed analysis of noise energy in DSL frequency bands:

Frequency Range	4 KHz to 1500 KHz
Frequency Band Sampling Range	4 KHz minimum
Power Spectral Density Range	0 dBrN to +120 dBrN
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

Tone Generation & Measurement - Applies and measures high frequency tones:

Frequency Range	4 KHz to 1500 KHz
Signal Level Range	-30 dBm to +30 dBm
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

Impulse Noise - Measures impulse noise at any frequency over DSL frequency range:

Event Threshold Range	-70 dBm to +30 dBm
Effective Frequency Range	4 KHz to 1500 KHz
Length of Test	10 to 3600 seconds

Longitudinal Balance (Metallice to Longitudinal and Vice Versa) - Longitudinal balance measurements verify the susceptibility of a copper pair to crosstalk and other noise sources:

Frequency Range	4 KHz to 1500 KHz

Frequency Band Sampling Width	4 KHz minimum
Circuit Balance Range	0 dB to +60 dB
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

Bridge Tap Detection - Bridge taps may severely limit the reach and speed of DSL signals due to reflections:

Range	up to 12,000 feet

Control and Management - Works with remote test unit.

Referring now to FIGS. 2 and 3, there are illustrated two flow charts showing the high level operation of the Bandwidth Analysis Tool (BAT) of the present invention and the operation of the BAT engine, as shown in FIG. 3. For purposes of illustration, the flow charts begin with reference numbers in the 100 series.

As shown in FIG. 2, the BAT system begins operation (Block 100) and a determination is made whether the mode equals the "best technology" (Block 101). There are two modes of operation: the first mode is the qualification of a line for a specific technology; the second mode recommends the best technology based on the application. In this flow chart, a determination is made of what mode the user desires to run, and if the mode equals the best technology, then a recommendation is received from a configurable list. The system software of the BAT queries a look-up table to obtain the first technology recommended for the application, and then qualifies the loop for that technology. As shown in Block 102, a recommendation order is obtained from a configurable list. The system sets a False status for "Done" (Block 104). The technology is set for the next technology (Block 106). If the last technology is not

equal to the technology (Block 108), then the BAT engine is called (Block 110). If the technology does equal the last technology, then "Done" is set to true (Block 111) and then the BAT engine run. If there is success in running the BAT engine (Block 112), then the technology, data rate and other status are returned (Block 114). If there is no success, and "Done" equals true (Block 116), then a failure is returned (Block 118). The system BAT software goes through the technology list until the loop qualifies for a technology, and then returns to the path and data rates. If it fails, then the loop did not qualify for any technologies for the application.

FIG. 3 illustrates the operation of the BAT engine by means of the high level flow chart as illustrated. The BAT engine is run (Block 170), and physical loop faults are determined (Block 172), such as by testing for shorts and testing for opens, and other similar tests. If there has been a failure (Block 174), then the status is set to failed (Block 176). If there has not been a failure, then the loop is qualified by testing for a load coil, impulse noise count, number of ringers, and other similar tests (Block 178). If there has been a failure based on the loop qualification (Block 179), then the status is set to failed (Block 176). If not, then the status is set to PASSED (Block 180) and Loop Quantification occurs (Block 182). At this point, the loop is modeled and the received signal PSD is calculated, as well as the signal-to-noise ratio. Data rates are calculated. Statuses and data rates are then returned (Block 184).

For purposes of description, the pseudo-code for the bandwidth analysis tool software module is explained below. These various pseudo-code segments are taken in order and described, starting with the

highest level and following to more detailed aspects of the Bandwidth Analysis Tool. Various inputs and outputs are described, as well as functions that are accomplished.

```
1. Pseudo-code BAT Engine
Inputs:
    Test Results from WTP, RTU and Plant data
    Threshold Data (technology and sub_tech dependent),
from a setup table
    Downstream and Upstream transmit Signal Data
(technology dependent),
    Technology ID

Outputs:
    Pass/Fail status
    Reason for failure and/or status information
    Downstream data rate
    Upstream data rate

Determine Physical Loop Faults
Analyze loop for xDSL
end of BAT Engine pseudo-code
```

As illustrated with the pseudo-code of the BAT engine, the various inputs include test results from the Wideband Test Pack, the Remote Test Unit and plant data. There are various thresholds that are technology dependent, such as the ringers and number of impulses that the technology will tolerate. These factors are all technology dependent and different thresholds are established for that specific technology, as known to those skilled in the art. This threshold data can be obtained from a set up table for the technology. Additionally, downstream and upstream transmit signal data are technology dependent. Examples include the level of the signal at the transmitter end, and the Power Spectral Density (PSD) of the signal that is allowed for specific technologies. For example, for various types of xDSL technology, the Power Spectral Density cannot exceed certain masks (or templates) for

each technology used at the transmit signal level. The technology ID confirms the technology identification.

The outputs can include a pass/fail status, reasons, and status information to show a lack of needed input data to form a concrete analysis. There could be some confidence level that is gained concerning the analysis and the reasons why the test may have failed or passed, such as if there were detected ringers, bridge taps and other similar items. The downstream/upstream data rate also is obtained.

At the next level, the loop is analyzed for xDSL, corresponding to the various DSL technologies. This occurs after the determination of physical loop faults.

2. Pseudo-code to Determine Physical Loop Faults

```
Inputs:
    Test Results from WTP, RTU and Plant data
    Technology dependent Threshold Data (technology
dependent)
    Technology ID

Outputs:
    Pass/Fail status
    Reason of failure

If Load Coil Information is Available

If Load Coil Present
    Set PassFail = FAIL;
    Set status Load Coil Present;

else
    Set PassFail = PASS;

else
    Set Reason for failure, Load Coil Information Not
Available
```

Physical loop faults are determined with similar inputs as before, such as the test results from the WTP, RTU and plant data. It is technology

dependent with threshold data, and a technology ID. The outputs include a pass/fail status and the reason for the failure. Load coil information is necessary to determine the physical loop faults because the load coils have an adverse effect on the DSL technology. Based on the xDSL technology, a different analysis is accomplished. The system also checks to determine what technology the system is qualifying the loop, such as symmetric DSL or asymmetic DSL.

3. Pseudo-code to Analyze XDSL

```
Inputs:
    Test Results from WTP, RTU and Plant data,
    Threshold Data (technology dependent),
    Downstream and Upstream transmit Signal Data
(technology dependent),
    Technology ID

Outputs:
    Pass/Fail status
    Reason of failure
    Downstream data rate
    Upstream data rate

    switch (Technology ID)

        // symmetric technologies
        case BAT_HDSL:
        case BAT_HDSL_1160:
        case BAT_HDSL_584:
        case BAT_HDSL_392:

        case BAT_SDSL:
        case BAT_SDSL_144:
        case BAT_SDSL_400:
        case BAT_SDSL_784:
        case BAT_SDSL_1040:
        case BAT_IDSL:
            Analyze Symmetric DSL;
        break;

        // Asymmetric technologies
        case BAT_ADSL:
        case BAT_RADSL:
        case BAT_HDSL2:
        Analyze Asymmetric DSL;
```

```
        // VDSL is processed separately
        case BAT_VDSL:
        AnalyzeVDSL;
        break;

        default:
            set PassFail = FAIL
        set Reason for failure, technology not
supported

        // end switch (Technology ID)
        // end Analyze XDSL
```

When analyzing the xDSL, it is evident that an analysis occurs based on the technology with a different analysis depending on what technology is being analyzed, such as HDSL, SDSL, ADSL, RADSL, HDSL2 and other possible xDSL technologies.

4. Pseudo-code to Analyze Symmetric DSL

```
Inputs:
    Test Results from WTP, RTU and Plant data
    Threshold Data (technology dependent)
    Downstream and upstream transmit Signal Data
(technology dependent)
    Technology ID

Outputs:
    Pass/Fail status
    Reason of failure
    Downstream data rate
    Upstream data rate

    Qualify Loop
    if Loop Qualified

        switch (Technology ID)

            case BAT_HDSL:
            case BAT_HDSL_1160:
            case BAT_HDSL_584:
            case BAT_HDSL_392:
                Quantify HDSL
                break;

            case SDSL:
                case SDSL_144:
                case SDSL_400:
```

```
            case SDSL_784:
            case SDSL_1040:
            case SDSL_1568:
                QuantifySDSL
            break;

            case BAT_IDSL:
                Quantify IDSL
            break;

        // end switch (Technology ID)

// end Analyze Symmetric DSL
```

When analyzing symmetric DSL, the loop is first qualified and then the BAT system quantifies HDSL, followed by quantifying SDSL, and then IDSL.

5. Pseudo-code to Analyze Asymmetric DSL

```
Inputs:
    Test Results from WTP, RTU and Plant data,
    Threshold Data (technology dependent),
    Signal Data (technology dependent),
    Technology ID

Outputs:
    Pass/Fail status
    Reason for failure
    Downstream data rate
    Upstream data rate

    Qualify Loop
    Quantify Loop

// end Analyze Asymmetric DSL
```

When analyzing asymmetric DSL, test inputs are similar as before, and the outputs include a reason for failure after a pass/fail status, a downstream data rate, and upstream data rate. The loop is qualified with one routine, and then quantified with another routine, as defined in the next two sections of pseudo-code, which explain the qualification and

quantification of the loop in accordance with the present invention.

6. Pseudo-code to Qualify Loop

```
Inputs:
    Test Results from WTP, RTU and Plant data,
    Threshold data (technology dependent),
    Technology ID

Outputs:
    Pass/Fail status
    Reason of failure

    if Load coil information available

        if Load coil present
            set Pass/Fail status = FAIL;
            Set Reason of failure status, Load Coil
Present  = TRUE;
        else

        LcoilPresent Status = FALSE;

    else

        set status Load Coil Information Not Available
= NOT_AVAIALBALE;

    if Impulse Noise test results available

        if Impulse Noise Count less than threshold
count

        set status ImpulseCountHigh = PASS

        else

            set status PassFail = FAIL
            set status ImpulseCountHigh = FAIL

    else

    set status WimpulseTestNotAvailable = NOT_AVAILABLE

    if Number of Ringers less than threshold
        set Reason of failure status RingerFault = PASS
    else
        set status PassFail = FAIL
        set Reason of failure status RingerFault = FAIL

//  end Qualify Loop
```

When qualifying the loop, various test results from the WTP, RTU and plant data are input, together with the threshold data and technology ID. The outputs include a pass/fail status and the reason for the failure. For example, load coil information, impulse noise test, and the number of ringers is determined. In the quanitification of the loop, signal data is also an input with the data rates as an output. The loop is modeled and can be identical for both directions. The Power Spectral Density (PSD) of transmit data is established for downstream transfers, and a signal-to-noise ratio array is set up for downstream transfers. The downstream data rate is calculated and the Power Spectral Density of transmit data is established for upstream transfers. The signal-to-noise ratio array is established. The upstream data rate is then calculated.

7. Pseudo-code to Quantify Loop

```
Inputs:
    Test Results from WTP, RTU and Plant data,
    Threshold data (technology dependent),
    Signal Data (technology dependent),
    Technology ID

Outputs:
    Pass/Fail status
    Reason of failure
    Downstream data rate
    Upstream data rate

    Model Loop (note: currently identical for both
directions)
    setup power spectral density of transmit data for
downstream transfers
    setup downstream signal-to-noise-ratio array
    calculate downstream data rate

    setup power spectral density of transmit data for
upstream transfers
    setup upstream signal-to-noise-ratio array
    calculate upstream data rate

//  end Quantify Loop
```

For the signal-to-noise ratio, the loop is modeled to determine loop attenuation at the receiving end. A signal-to-noise ratio is calculated using the well known Shannon Theorem to calculate the downstream data rate.

Shannon's Theorem gives an upper bound to the capacity of a link, in bits per second (bps), as a function of the available bandwidth and the signal-to-noise ratio of the link. The theorem can be stated as:

$$C = B * \log2 (1 + S/N)$$

where C is the achievable channel capacity, B is the bandwidth of the line, S is the average signal power, and N is the average noise power. The signal-to-noise ratio (S/N) is usually expressed in decibels (dB) given by the formula:

$$10 * \log10 (S/N).$$

Thus, a signal-to-noise ratio of 1,000 could commonly be expressed as:

$$10 * \log10 (1000) = 30 \text{ dB}.$$

The pseudo-codes to model the loop and to calculate the loop's ABCD matrices are set forth below. The loop is modeled using inputs as the number of channels, the start frequency, the delta frequency, test results, and technology ID with an output as loop data. Source and load impedances are used, together with the wire gauge information, if available. When calculating the loop's ABCD matrices, the inputs include the number of channels, the start frequency, delta frequency, length of the segment, wire gauge, bridged tap flag, and loop data. The RLCG constants are also modeled (Resistance, Inductance, Capacitance and Conductance), together with the model line parameters. Following the pseudo-code for calculating the loop's ABCD matrices, the pseudo-codes to model the primary constants RLCG,

the insertion loss, the line parameters, the signal-to-noise ratio, and the data rate are set forth.

8. Pseudo-code to Model Loop

```
Inputs:
    Number of Channels,
    Start Frequency,
    Delta Frequency,
    Test Results,
    Technology ID,

Outputs:
    Loop Data

    set source and load impedances
    If Wire Gauge Information available
       Set Wire Gauge
    Else
       Set Wire Gauge to default wire gauge

    If Bridged Tap Information is not available
       Set number of taps to zero
    Else
       Calculate Loop's ABCD matrices

    Calculate Insertion Loss of the loop

// end Model Loop
```

9. Pseudo-code to Calculate Loop's ABCD Matrices

```
Inputs:
    Number of Channels
    Start Frequency
    Delta Frequency
    Length of the segment
    Wire Gauge
    Bridged Tap Flag
    Loop Data

Output:
    Loop Data

    initialize loop [ABCD] to unity
    do for all segments of the loop

       Do for the frequency range
          Model the RLCG Constants
          Model Line Parameters
          If it is Bridged Tap section
```

```
                    A = 1
                    B = 0
                    C = Ctanh (Gamma)
                    D = Ctanh(Gamma)/Z0;
else
                    A = D = Ccosh (Gamma)
                    B = Csinh(Gamma) * Z0;
                    C = Csinh(Gamma) /Z0;

Multiply by the accumulated [ABCD] from previous segments

        // end do for the frequency range
    end do for all segments of the loop

// end Calculate loop's ABCD matrices
```

10. Pseudo-code to Model the Primary Constants RLCG

```
Inputs:
     Frequency in kHz
     Wire Gauge

Outputs:
     Primary Constants, RLCG

     if Wire Gauge Information Available
          set cable model parameters based on the wire gauge
     else
          set cable model parameters using average of AWG_24 and AWG_26

     Calculate Primary Constants, RLCG
```

11. Pseudo-code to Calculate Insertion Loss

```
     Do for all channels
          set load impedance (Z_load) for the current technology
          set source impedance (Z_source) for the current technology
          Insertion Loss = 20 * log (abs ((A * Z_load + B + Z_source *
                    (C * Z_load +D))/Z_source + Z_load)))

// end of for all channels}  // end of Calculate Insertion Loss
```

12. Pseudo-code to Calculate Line Parameters

```
Inputs:
     Frequency
     Primary Constants (RLCG)

Outputs:
     Line Parameters

     Z = R + j*2*PI*f*L;
     Y = G + j 2PI*Frequency*C;
     Gamma = Csqrt(Z*Y);
     Z0 = CSqrt(Z/Y);

// end Calculate Line Paramters
```

13. Pseudo-code to Setup Signal to Noise Ratio

```
Inputs:
     Number of channels
     Start Frequency
     Delta Frequency
     PSD data
     Wmargin data
     Loop data
     Downstream flag

Outputs:
     Signal to noise ratio for all channels

Do for all channels
     convert transmit signal PSD from dBm/Hz to dB
     calculate signal level at receiver end
     convert noise to dB
     signal to noise [dB] = signal [dB] - noise [dB]

// end for all channels
// end Setup Signal to Noise Ratio
```

14. Pseudo-code to Calculate Data Rate

```
Inputs:
     Bat Results
     Number of Channels
     Start Frequency
     Delta Frequency
     Signal to noise data
     Technology ID
     Downstream flag
Outputs:
```

```
      Downstream/upstream data rate

      Switch (Technology ID)
           case BAT_ADSL:
           if (Downstream)
                for channels 33 through 255 (excluding
channel 64)
                     signal_to_noise [dB] =
signal_to_noise - snr_margin  - snr_gap
                     if (signal_to_nois > 0)

                     Delta Capacity  = log2(1 +
pow(10.0,0.1*signal_to_noise [dB]))
                     If (Delta Capacity > MAX_BIT)
                          Delta Capacity = MAX_BIT
                     If (Delta Capacity < MIN_BIT)
                          Delta Capacity = MIN_BIT

                     Downstream Data Rate = Downstream
Data Rate +
                     Delta Capapcity * data_frame_rate

           else
                for channels 6 through 31 (excluding
channel 16)
                     signal_to_noise [dB] =
signal_to_noise - snr_margin  - snr_gap
                     if (signal_to_noise > 0)

                     Delta Capacity  = log2(1 +
pow(10.0,0.1*signal_to_noise [dB]))
                     If (Delta Capacity > MAX_BIT)
                          Delta Capacity = MAX_BIT
                     If (Delta Capacity < MIN_BIT)
                          Delta Capacity = MIN_BIT

                     Upstream Data Rate = Upstream Data
Rate + Delta Capapcity * data_frame_rate

           break;

           case HDSL2:
           Not implemented yet

           break;

           case BAT_VDSL:

           break;

           default:
                for all channels
```

```
                    signal_to_noise ratio =
signal_to_noise ratio - snr_margin - snr_gap
                    if (signal_to_noise_ratio > 0)

                    Delta Capacity = log2(1 + pow(10,
0.1 * signal_to_noise ratio))
                    Total Capacity = Total Capacity +
Delta Capacity * data_frame_rate

// Calculate data rate
```

It is evident that the present invention is operable to take the raw data from various test units, and more particularly, the Wideband Test Pack, Remote Test Units, and plant record data to qualify and quantify a local loop under test for a particular DSL technology. Also, the WTP, RTU, and plant record data can be analyzed to recommend the best technology for a given application in an efficient manner.

Many modifications and other embodiments of the invention will come to the mind of one skilled in the art having the benefit of the teachings presented in the foregoing descriptions and the associated drawings. Therefore, it is to be understood that the invention is not to be limited to the specific embodiments disclosed, and that the modifications and embodiments are intended to be included within the scope of the dependent claims.

THAT WHICH IS CLAIMED IS:

1. A method of analyzing a telephone local loop comprising the steps of:

determining the physical loop faults within the local loop;

qualifying the local loop for a particular Digital Subscriber Line (DSL) technology; and

quantifying the local loop by calculating the signal-to-noise ratio and calculating the data rates of the local loop for a particular DSL technology.

2. A method according to Claim 1, wherein the particular DSL technology comprises symmetric DSL technology.

3. A method according to Claim 1, wherein the particular DSL technology comprises asymmetric DSL technology.

4. A method according to Claim 1, wherein the step of quantifying the local loop comprises the step of modeling the local loop.

5. A method according to Claim 4, wherein the step of modeling the local loop comprises the step of modeling the Resistance, Inductance, Capacitance, and Conductance (RLCG) primary constants and the line parameters for various segments of the local loop.

6. A method according to Claim 5, wherein the line parameters are modeled based on the frequency and RLCG primary constants.

7. A method according to Claim 1, wherein the step of determining physical loop faults includes the step of obtaining plant data and test results from a test head within a communications network containing the local loop.

8. A method according to Claim 1, wherein the step of qualifying the local loop comprises the step of testing for the presence or absence of load coils, impulse noise counts, and ringer counts, and then comparing the counts with thresholds specified by given DSL technologies.

9. A method according to Claim 1, wherein the step of quantifying the local loop comprises the step of calculating downstream and upstream data rates based on the downstream and upstream transmit signal Power Spectral Densities (PSD), insertion loss, and noise versus frequency measurements.

10. A method according to Claim 9, and further comprising the step of calculating the insertion loss of the local loop with or without bridged taps based on the cable type, wire gauge, loop length and its topology.

11. A method according to Claim 1, wherein the step of quantifying the local loop comprises the step selecting a particular DSL technology from a configurable list of DSL technologies and analyzing each technology within the list until local loop qualifies.

12. A method of analyzing a telephone local loop comprising the steps of:

determining the physical loop faults within the local loop;

qualifying the local loop for a particular Digital Subscriber Line (DSL) technology; and

quantifying the local loop by calculating the transmit signal Power Spectral Densities (PSD), and calculating upstream and downstream data rates for a particular DSL technology.

13. A method according to Claim 12, wherein the particular DSL technology comprises asymmetric DSL technology.

14. A method according to Claim 13, wherein the step of quantifying the local loop comprises the step of modeling the local loop topology for VDSL technology.

15. A method according to Claim 12, and comprising the step of modeling the local loop by modeling the Resistance, Inductance, Capacitance, and Conductance (RLCG) primary constants and the line parameters for various segments of the local loop.

16. A method according to Claim 15, wherein the line parameters are modeled based on the frequency and RLCG primary constants.

17. A method according to Claim 12, wherein the step of determining physical loop faults includes the step of obtaining test results from a test head within a communications network containing the local loop and plant data.

18. A method according to Claim 12, wherein the step of qualifying the local loop comprises the step of testing for the presence or absence of load coils, impulse noise counts, and ringer counts, and then comparing the counts with thresholds specified by given DSL technologies.

19. A method according to Claim 12, wherein the step of quantifying the local loop comprises the step of calculating downstream and upstream data rates based on the downstream and upstream transmit signal Power Spectral Densities (PSD), insertion loss, and noise versus frequency measurements.

20. A method according to Claim 19, and further comprising the step of calculating the insertion loss of the local loop with or without bridged taps based on the cable type, wire gauge, loop length and its topology.

21. A method according to Claim 12, wherein the step of quantifying the local loop comprises the step selecting a particular DSL technology from a configurable list of DSL technologies and analyzing each technology within the list until local loop qualifies.

22. A system for analyzing a telephone local loop comprising:

a central office operatively connected to a telephone local loop; and

a bandwidth analysis system operatively connected to the central office and operative for:

(a) determining the physical loop faults within the local loop;

(b) qualifying the local loop for a particular Digital Subscriber Line (DSL) technology; and

(c) quantifying the local loop by calculating the signal-to-noise ratio and calculating data rates for a particular DSL technology.

23. A system according to Claim 22, and further comprising a call center operatively connected to the central office, said call center having a test access controller and said bandwidth analysis system comprising a software module associated with said test access controller.

24. A system according to Claim 22, wherein the bandwidth analysis system further comprises a remote test unit for obtaining local loop line data.

25. A system according to Claim 22, wherein the bandwidth analysis system is operative for modeling the local loop.

26. A system according to Claim 25, wherein the bandwidth analysis system is operative for modeling the Resistance, Inductance, Capacitance, and Conductance (RLCG) primary constants and the line parameters for various segments of the local loop.

27. A system according to Claim 26, wherein the line parameters are modeled based on the frequency and RLCG primary constants.

28. A system according to Claim 22, wherein the bandwidth analysis system is operative for determining physical loop faults by obtaining plat data

and test results from a test head within a communications network containing the local loop.

29. A system according to Claim 22, wherein the bandwidth analysis system is operative for qualifying the local loop by testing for the presence or absence of load coils, impulse noise counts, and ringer counts, and then comparing the counts with thresholds specified by given DSL technologies.

30. A system according to Claim 22, wherein the bandwidth analysis system is operative for quantifying the local loop by calculating downstream and upstream data rates based on the downstream and upstream transmit signal power spectral densities (PSD), insertion loss, and noise versus frequency measurements.

31. A system according to Claim 30, wherein the bandwidth analysis system is operative for calculating the insertion loss of the local loop with or without bridged taps based on the cable type, wire gauge, loop length and its topology.

32. A system according to Claim 22, wherein the bandwidth analysis system is operative for selecting a particular DSL technology from a configurable list of DSL technologies and analyzing each technology within the list until local loop qualifies.

33. A system for analyzing a telephone local loop comprising:

a central office operatively connected to a telephone local loop; and

a bandwidth analysis system operatively connected to the central office and operative for:

(a) determining the physical loop faults within the local loop;

(b) qualifying the local loop for a particular Digital Subscriber Line (DSL) technology; and

(c) quantifying the local loop by calculating the transmit signal Power Spectral Densities (PSD), and calculating upstream and downstream data rates for a particular DSL technology.

34. A system according to Claim 33, and further comprising a call center operatively connected to the central office, said call center having a test access controller and bandwidth analysis system.

35. A system according to Claim 33, wherein the bandwidth analysis system further comprises a remote test unit for obtaining local loop line data.

36. A system according to Claim 33, wherein the bandwidth analysis system is operative for modeling the local loop.

37. A system according to Claim 36, wherein the bandwidth analysis system is operative for modeling the Resistance, Inductance, Capacitance, and Conductance (RLCG) primary constants and the line parameters for various segments of the local loop.

38. A system according to Claim 37, wherein the line parameters are modeled based on the frequency and RLCG primary constants.

39. A system according to Claim 33, wherein the bandwidth analysis system is operative for determining physical loop faults by obtaining plant data

and test results from a test head within a communications network containing the local loop.

40. A system according to Claim 33, wherein the bandwidth analysis system is operative for qualifying the local loop by testing for the presence or absence of load coils, impulse noise counts, and ringer counts, and then comparing the counts with thresholds specified by given DSL technologies.

41. A system according to Claim 33, wherein the bandwidth analysis system is operative for quantifying the local loop by calculating downstream and upstream data rates based on the downstream and upstream transmit signal power spectral densities (PSD), insertion loss, and noise versus frequency measurements.

42. A system according to Claim 33, wherein the bandwidth analysis system is operative for calculating the insertion loss of the local loop with or without bridged taps based on the cable type, wire gauge, loop length and its topology.

43. A system according to Claim 33, wherein the bandwidth analysis system is operative for selecting a particular DSL technology from a configurable list of DSL technologies and analyzing each technology within the list until a local loop qualifies.

SYSTEM AND METHOD FOR BROADBAND ANALYSIS OF TELEPHONE LOCAL LOOP

Abstract of the Disclosure

A method and system analyzes a telephone local loop and includes a central office operatively connected to the telephone local loop. A bandwidth analysis system is operatively connected to the central office and operative for determining the physical loop faults within the loop; qualifying the local loop for a particular Digital Subscriber Line (DSL) technology; and quantifying the local loop by calculating the transmit signal Power Spectral Densities (PSD) and calculating upstream and downstream data rates for particular DSL technology.

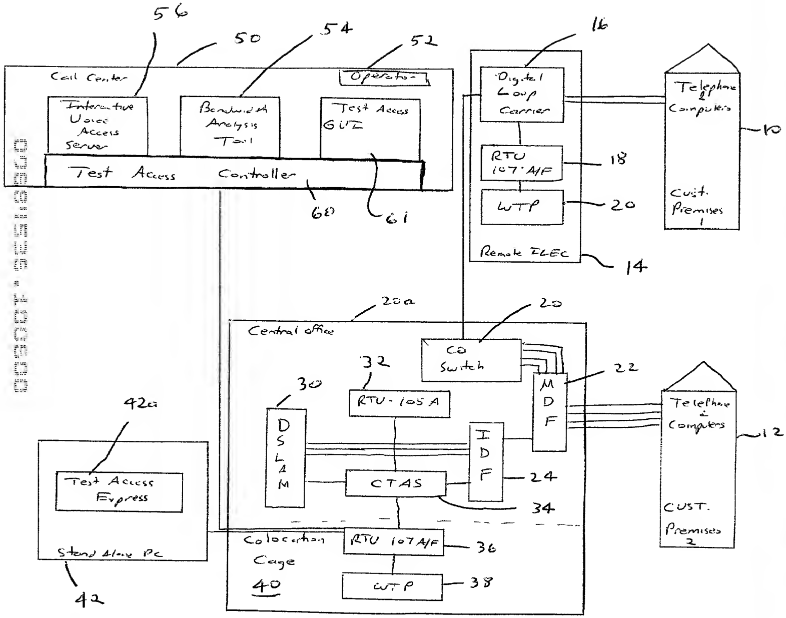
56
50
54
52
16
Call Center
Operator
Interactive Voice Access Server
Bandwidth Analysis Tool
Test Access GUI
Test Access Controller
60
61
Digital Loop Carrier
RTU 107 A/F
18
WTP
20
Remote ILEC
14
Telephone & Computers
Cust. Premises 1
10
20a
20
Central office
CO Switch
32
30
22
RTU-105A
M D F
D S L A M
I D F
CTAS
24
34
Telephone & Computers
Cust. Premises 2
12
42a
Test Access Express
Stand Alone PC
42
Colocation Cage
40
RTU 107 A/F
36
WTP
38

FIG. 1

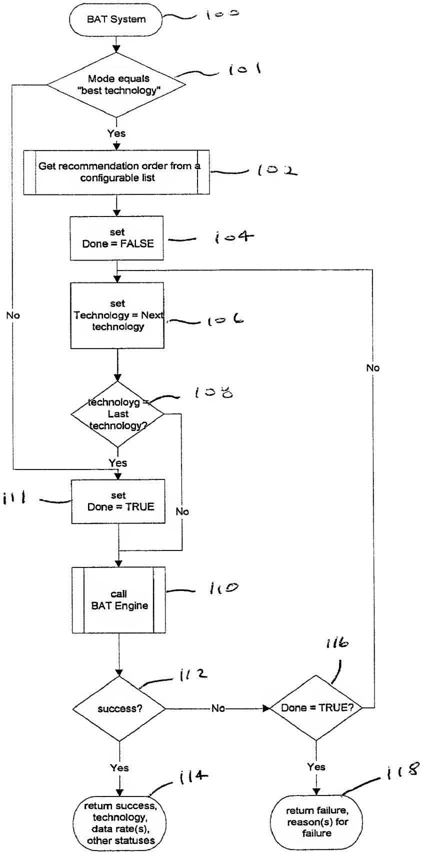
BAT System
100
Mode equals "best technology"
101
Yes
No
Get recommendation order from a configurable list
102
set Done = FALSE
104
set Technology = Next technology
106
technoloyg = Last technology?
108
Yes
No
No
set Done = TRUE
111
call BAT Engine
110
success?
112
No
Done = TRUE?
116
Yes
114
return success, technology, data rate(s), other statuses
Yes
118
return failure, reason(s) for failure

FIG. 2

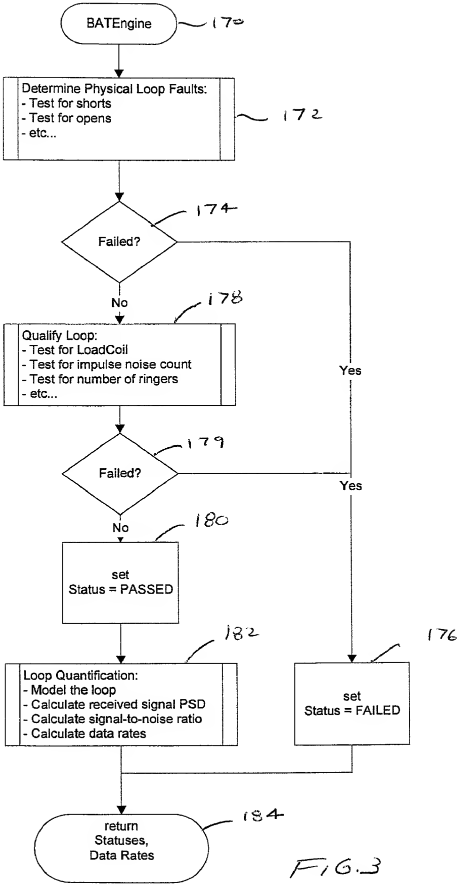
BATEngine
170
Determine Physical Loop Faults:
- Test for shorts
- Test for opens
- etc...
172
Failed?
174
Yes
No
Qualify Loop:
- Test for LoadCoil
- Test for impulse noise count
- Test for number of ringers
- etc...
178
Failed?
179
Yes
No
set
Status = PASSED
180
Loop Quantification:
- Model the loop
- Calculate received signal PSD
- Calculate signal-to-noise ratio
- Calculate data rates
182
set
Status = FAILED
176
return
Statuses,
Data Rates
184

FIG.3